

Search Notes



Application/Control No.

10/822,130

Examiner

David Q. Nguyen

Applicant(s)/Patent under Reexamination

CHO ET AL.

Art Unit

2681

SEARCHED

Class	Subclass	Date	Examiner
455	441	09/16/05	DN
455	533.1		
455	130		
455	67.11		
455	436		
600	454		
702	142		
325	130		
1	285		
325	722	09/16/05	DN
325	130		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
All	above	09/15/06	DN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Text search	09/16/05	DN